

# UNISONIC TECHNOLOGIES CO., LTD

6N60-ML **Preliminary Power MOSFET** 

## 6.0A, 600V N-CHANNEL **POWER MOSFET**

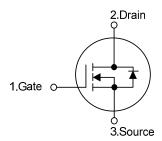
#### DESCRIPTION

The UTC 6N60-ML is a high voltage power MOSFET combines advanced planar MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

#### **FEATURES**

- \*  $R_{DS(ON)} \le 1.7 \Omega @ V_{GS}=10V, I_D=3.0A$
- \* Fast switching capability
- \* Avalanche energy tested
- \* Improved dv/dt capability, high ruggedness

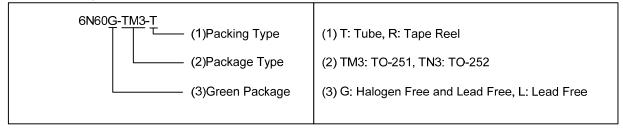




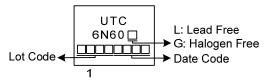
#### **ORDERING INFORMATION**

Ordering Number		Doolsons	Pin	Assignm	Deeking		
Lead Free	Halogen Free	Package	1	2	3	Packing	
6N60L-TM3-T	6N60G-TM3-T	TO-251	G	D	S	Tube	
6N60L-TN3-R	6N60G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



## **MARKING**



TO-251 TO-252

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## ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Drain-Source Voltage	$V_{DSS}$	600	<b>V</b>
Gate-Source Voltage	$V_{GSS}$	±30	<b>V</b>
Continuous Drain Current	I <sub>D</sub>	6	Α
Pulsed Drain Current (Note 2)	I <sub>DM</sub>	12	Α
Avalanche Energy Single Pulsed (Note 3)	E <sub>AS</sub>	216	mJ
Peak Diode Recovery dv/dt (Note 4)	dv/dt	2.8	V/ns
Power Dissipation	$P_D$	50	W
Junction Temperature	TJ	+150	°C
Storage Temperature	T <sub>STG</sub>	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 30mH,  $I_{AS}$  = 3.8A,  $V_{DD}$  = 50V,  $R_G$  = 25  $\Omega$ , Starting  $T_J$  = 25°C
- 4.  $I_{SD} \le 6.0$ A, di/dt  $\le 200$ A/ $\mu$ s,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25$ °C

## **■ THERMAL DATA**

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	$\theta_{JA}$	110	°C/W	
Junction to Case	$\theta_{JC}$	2.5 (Note)	°C/W	

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

## ■ **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub>=25°C, unless otherwise specified)

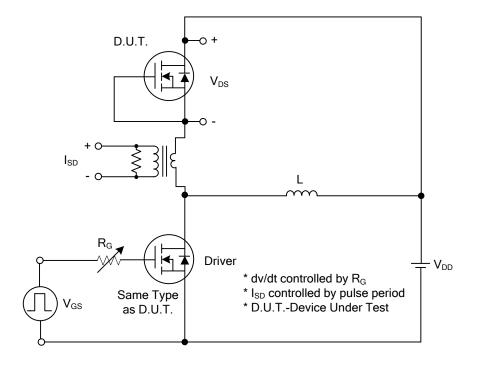
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	$V_{GS}$ =0V, $I_D$ =250 $\mu$ A	600			V
Drain-Source Leakage Current		I <sub>DSS</sub>	V <sub>DS</sub> =600V, V <sub>GS</sub> =0V			10	μΑ
Gate- Source Leakage Current	Forward	I <sub>GSS</sub>	V <sub>GS</sub> =30V, V <sub>DS</sub> =0V			100	nA
	Reverse		$V_{GS}$ =-30V, $V_{DS}$ =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$ , $I_D=250\mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =3.0A			1.7	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance	put Capacitance				790		pF
Output Capacitance		Coss	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1.0MHz		74		pF
Reverse Transfer Capacitance		C <sub>RSS</sub>			5.5		pF
SWITCHING CHARACTERISTICS	S						
Total Gate Charge (Note 1)		$Q_{G}$	\\ -480\\ \\ -10\\   -6A		22		nC
Gate-Source Charge		$Q_GS$	V <sub>DS</sub> =480V, V <sub>GS</sub> =10V, I <sub>D</sub> =6A I <sub>G</sub> =1mA (Note 1, 2)		7		nC
Gate-Drain Charge		$Q_GD$	IG-IIIIA (Note 1, 2)		5		nC
Turn-On Delay Time (Note 1)		t <sub>D(ON)</sub>			11		ns
Turn-On Rise Time		t <sub>R</sub>	V <sub>DS</sub> =100V, V <sub>GS</sub> =10V, I <sub>D</sub> =6A,		18		ns
Turn-Off Delay Time		t <sub>D(OFF)</sub>	R <sub>G</sub> =25Ω (Note 1, 2)		50		ns
Turn-Off Fall Time		t <sub>F</sub>			26		ns
DRAIN-SOURCE DIODE CHARA	CTERISTICS	AND MAXII	MUM RATINGS				
Maximum Body-Diode Continuous Current		Is				6	Α
Maximum Body-Diode Pulsed Current		I <sub>SM</sub>				12	Α
Drain-Source Diode Forward Voltage (Note 1)		$V_{SD}$	I <sub>S</sub> =6A , V <sub>GS</sub> =0V			1.4	V
Reverse Recovery Time (Note 1)		t <sub>rr</sub>	I <sub>S</sub> =6A , V <sub>GS</sub> =0V		340		ns
Reverse Recovery Charge		Q <sub>rr</sub>	di/dt=100A/μs		5		μC

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

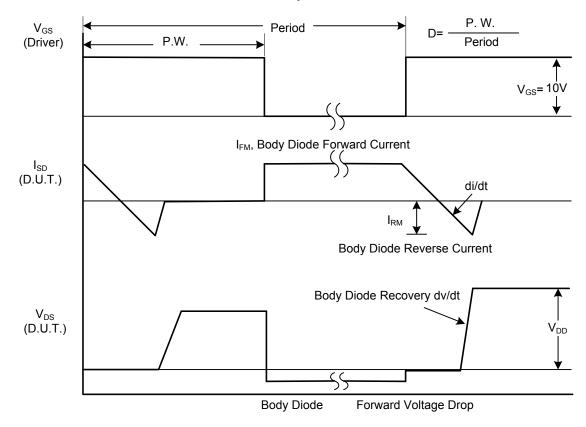
2. Essentially independent of operating temperature.



## **■ TEST CIRCUITS AND WAVEFORMS**

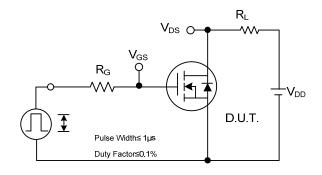


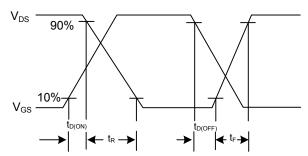
## Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

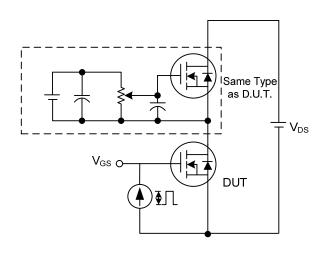
## **■ TEST CIRCUITS AND WAVEFORMS**

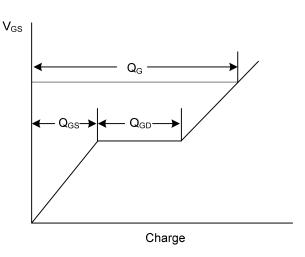




**Switching Test Circuit** 

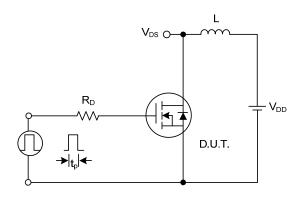
**Switching Waveforms** 

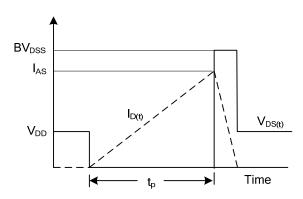




**Gate Charge Test Circuit** 

**Gate Charge Waveform** 





**Unclamped Inductive Switching Test Circuit** 

**Unclamped Inductive Switching Waveforms** 

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